Testing Service	Appendix D for the BlackBerry Report	® Smartphone Model	REQ71UW SAR	Page 1(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

APPENDIX D: PROBE & DIPOLE CALIBRATION DATA



Document

Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

Page **2(53)**

Author Data
Andrew Becker

Dates of Test

September 27 – October 26, 2011

Test Report No

RTS-5955-1110-23

FCC ID:

L6AREQ70UW

1C ID **2503A-REQ70UW**

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





S Schweizerlscher Kalibrierdienst
C Service suisse d'étalonnage

Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client RTS (RIM Testing Services)

Accreditation No.: SCS 108

S

Certificate No: ES3-3225_Jan11

CALIBRATION CERTIFICATE

Object

ES3DV3 - SN:3225

Calibration procedure(s)

QA CAL-01.v7, QA CAL-23.v4 and QA CAL-25.v3 Calibration procedure for dosimetric E-field probes

Calibration date: January 13, 2011

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	1D #	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41495277	1-Apr-10 (No. 217-01136)	Apr-11
Power sensor E4412A	MY41498087	1-Apr-10 (No. 217-01136)	Apr-11
Reference 3 dB Attenuator	SN: S5054 (3c)	30-Mar-10 (No. 217-01159)	Mar-11
Reference 20 dB Attenuator	SN: S5086 (20b)	30-Mar-10 (No. 217-01161)	Mar-11
Reference 30 dB Attenuator	SN: S5129 (30b)	30-Mar-10 (No. 217-01160)	Mar-11
Reference Probe ES3DV2	SN: 3013	29-Dec-10 (No. ES3-3013_Dec10)	Dec-11
DAE4	SN: 660	20-Apr-10 (No. DAE4-660_Apr10)	Apr-11
Secondary Standards	ID#	Check Date (in house)	Scheduled Check
RF generator HP 8648C	US3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585	18-Oct-01 (in house check Oct-10)	In house check: Oct-11

Na Na Function

I aboratore Tacheleian

Approved by:

Calibrated by:

atja Pokovic

Technical Manager

Issued: January 15, 2011

Signature

This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: ES3-3225_Jan11

Page 1 of 11



Document

Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

Page **3(53)**

Author Data
Andrew Becker

Dates of Test

September 27 - October 26, 2011

Test Report No

RTS-5955-1110-23

FCC ID:

L6AREQ70UW

1C ID **2503A-REQ70UW**

Calibration Laboratory of

Schmid & Partner
Engineering AG
Zeughausstrasse 43, 8004 Zurich, Switzerland





С

S Schweizerischer Kalibrierdienst

Service suisse d'étalonnage

Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:
TSL tissue simulating liquid
NORMx,y,z sensitivity in free space
ConvF sensitivity in TSL / NORMx,y,z
DCP diode compression point

CF crest factor (1/duty_cycle) of the RF signal A, B, C modulation dependent linearization parameters

Polarization φ rotation around probe axis

Polarization 9 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., 9 = 0 is normal to probe axis

Calibration is Performed According to the Following Standards:

- IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- EC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 (f ≤ 900 MHz in TEM-cell; f > 1800 MHz: R22 waveguide).
 NORMx,y,z are only intermediate values, i.e., the uncertainties of NORMx,y,z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x,y,z = NORMx,y,z * frequency_response (see Frequency Response Chart). This linearization is
 implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included
 in the stated uncertainty of ConvF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z; A, B, C are numerical linearization parameters assessed based on the data of
 power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the
 maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Certificate No: ES3-3225 Jan11 Page 2 of 11

Testing Service	Page 4(53)			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

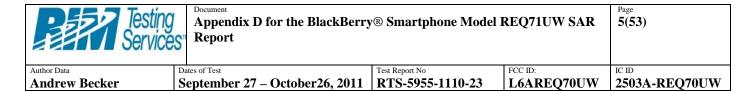
Probe ES3DV3

SN:3225

Manufactured: September 1, 2009 Last calibrated: December 11, 2009 Recalibrated: January 13, 2011

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)



DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m) ²) ^A	1.26	1.21	1.31	± 10.1%
DCP (mV) ⁸	102.1	100.8	99.1	

Modulation Calibration Parameters

UID	Communication System Name	PAR		A dB	B dBuV	С	VR mV	Unc ^E (k=2)
10000	cw	0.00	×	0.00	0.00	1.00	149.8	± 2.6 %
			Υ	0.00	0.00	1.00	148.1	
			Z	0.00	0.00	1.00	110.7	

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: ES3-3225_Jan11

^a The uncertainties of NormX,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

⁶ Numerical linearization parameter, uncertainty not required.

^c Uncertainty is determined using the maximum deviation from linear response applying recatangular distribution and is expressed for the square of the field value.

Testing Service	Page 6 (53)			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

ES3DV3 SN:3225

January 13, 2011

DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X Co	nvFY Con	vF Z	Alpha	Depth Unc (k=2)
750	±50/±100	$41.9 \pm 5\%$	$0.89 \pm 5\%$	6.47	6.47	6.47	0.89	1.08 ± 11.0%
900	±50/±100	41.5 ± 5%	0.97 ± 5%	6.11	6.11	6.11	0.81	1.10 ± 11.0%
1810	±50/±100	40.0 ± 5%	$1.40 \pm 5\%$	5.26	5.26	5.26	0.37	1.68 ± 11.0%
1950	±50/±100	$40.0\pm5\%$	$1.40 \pm 5\%$	4.98	4.98	4.98	0.48	1.51 ± 11.0%
2450	±50/±100	39.2 ± 5%	1.80 ± 5%	4.60	4.60	4.60	0.52	1.54 ± 11.0%
2600	$\pm 50 / \pm 100$	$39.0 \pm 5\%$	1.96 ± 5%	4.52	4.52	4.52	0.53	1.58 ± 11.0%

^c The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Testing Service	Page 7 (53)			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

ES3DV3 SN:3225

January 13, 2011

DASY/EASY - Parameters of Probe: ES3DV3 SN:3225

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz]	Validity [MHz] ^C	Permittivity	Conductivity	ConvF X Co	nvFY Co	nvF Z	Alpha	Depth Unc (k=2)
750	±50/±100	$55.5 \pm 5\%$	$0.96 \pm 5\%$	6.30	6.30	6.30	0.76	1.17 ± 11.0%
900	±50/±100	$55.0\pm5\%$	1.05 ± 5%	6.12	6.12	6.12	0.72	1.20 ± 11.0%
1810	±50/±100	53.3 ± 5%	1.52 ± 5%	4.88	4.88	4.88	0.26	2.70 ± 11.0%
1950	±50/±100	$53.3 \pm 5\%$	1.52 ± 5%	4.89	4.89	4.89	0.33	2.28 ± 11.0%
2450	± 50 / ± 100	52.7 ± 5%	$1.95 \pm 5\%$	4.43	4.43	4.43	0.99	1.04 ± 11.0%
2600	±50/±100	52.5 ± 5%	2.16 ± 5%	4.29	4.29	4.29	0.99	1.05 ± 11.0%

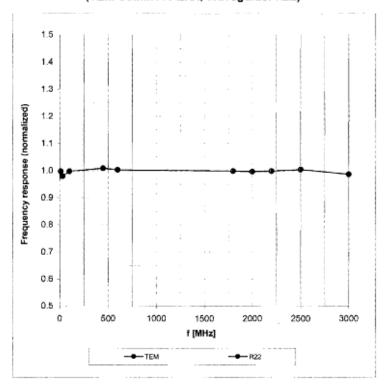
^C The validity of ± 100 MHz only applies for DASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Certificate No: ES3-3225_Jan11

Testing Service	Page 8 (53)			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Frequency Response of E-Field

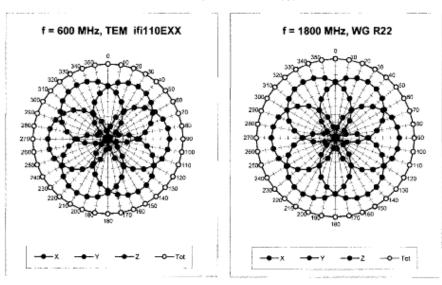
(TEM-Cell:ifi110 EXX, Waveguide: R22)

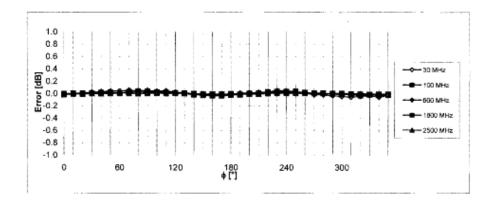


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Testing Service	Page 9 (53)			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



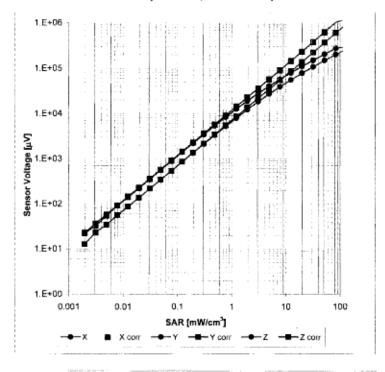


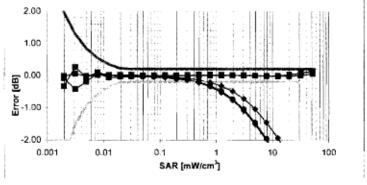
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Testing Service	Page 10(53)			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

Dynamic Range f(SAR_{head})

(TEM cell, f = 900 MHz)

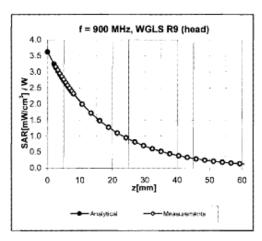


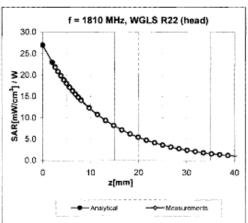


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Testing Service	Appendix D for the BlackBerry Report	Page 11(53)		
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

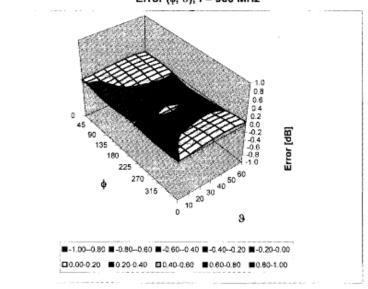
Conversion Factor Assessment





Deviation from Isotropy in HSL

Error (ϕ , ϑ), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Testing Service	Appendix D for the BlackBerry Report	Page 12(53)		
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

ES3DV3 SN:3225

January 13, 2011

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	2 mm
Probe Tip to Sensor Y Calibration Point	2 mm
Probe Tip to Sensor Z Calibration Point	2 mm
Recommended Measurement Distance from Surface	3 mm

Testing Services	- 1 1	Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR			
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID	
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW	



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

14(53)

Author Data Andrew Becker Dates of Test

September 27 – October 26, 2011

Test Report No RTS-5955-1110-23 FCC ID:

L6AREQ70UW

IC ID 2503A-REQ70UW

Calibration Laboratory of Schmid & Partner Engineering AG Zoughausstrasse 43, 8004 Zurich, Switzerland





Bohweizerischer Kalibrierdienst Service suisse d'étalonnage С Sarvizio svizzero di taratura **Swise Calibration Service**

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

RTS (RIM Testing Services) Client

Accreditation No.: SCS 108

Corolless No: EX3-3592_Nov10

CALIBRATION CERTIFICATE

Object EX3DV4 - \$N:3592

QA CAL-01.v6, QA CAL-14.v3, QA CAL-23.v3 and QA CAL-25.v2 Calibration procedure(s)

Calibration procedure for dosimetric E-field probes

Calibration date. November 18, 2010

This calibration certificate documents the traceptility to national standards, which realize the physical units of measurements (SI) The measurements and the uncertainties with confidence probability are given on the following pages and are part of the confidate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M8TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter E4419B	GB41293874	1-Apr-10 (No. 217-01138)	Apr-11
Power sensor E4412A	MY41495277	1-Apr-10 (No. 217-01135)	Apr-11
Power sensor E4412A	MY41498087	1-Apr-10 (No. 217-01136)	Apr-11
Reference 3 dB Attenuator	SN: 65054 (3c)	30-Mar-10 (No. 217-01159)	Mar-11
Reference 20 dB Attenuation	SN: 55086 (20b)	30-Mar-10 (No. 217-01161)	Mar-11
Reference 30 dB Attenuator	SN: 55129 (30b)	30-Mar-10 (No. 217-01160)	Mar-11
Reference Probe ES3DV2	SN: 3013	30-Dec-09 (No. ES3-3013_Dec09)	Dec-10
DAE4	SN: 880	20-Apr-10 (No DAE4-660_Apr-10)	Apr-11
Secondary Standards	ID#	Check Dale (in house)	Scheduled Check
RF generator HP 8546C	U\$3642U01700	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	U\$37390565	18-Oct-01 (in house check Oct-10)	In house check, Oct-11
	Name	Function	Signature
Calibrated by:	Katja Pokovic	Technical Manager	6000
			1 1 101 2
Approved by:	Niele Kuster	Cruelty Menager	// /

Issued, November 20, 2010

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No. EX3-3592_Nov10



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

15(53)

Author Data Andrew Becker Dates of Test

September 27 – October 26, 2011

Test Report No RTS-5955-1110-23

FCC ID: L6AREO70UW IC ID 2503A-REQ70UW

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizer/scher Kalibrierdienst S Service suisse d'étatonnage C Servizio svizzero di taratura s Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service [SAS] The Swiss Accreditation Service is one of the signatories to the EA Multifateral Agreement for the recognition of calibration certificates

Glossary:

tissue simulating liquid TSLNORMx,y,2 sensitivity in free space. ConvE sensitivity in TSL / NORMx,y,z DCP diode compression point

ĊF crest factor (1/duty_cycle) of the RF signal A, B, C modulation dependent linearization parameters

Polarization ϕ φ rotation around probe axis:

Polarization 8 9 rotation around an axis that is in the plane normal to probe axis (at measurement center),

i.e., 9 = 0 is normal to probe axis.

Calibration is Performed According to the Following Standards:

- al IEEE Std 1528-2003, *IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003.
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005.

Methods Applied and Interpretation of Parameters:

- NORMx,y,z: Assessed for E-field polarization 9 = 0 (1 \leq 900 MHz in TEM-cell; f > 1800 MHz; R22 wavequide). NGRMx.y.z are only intermediate values, i.e., the uncertainties of NORMx.y.z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x, y, z = NORMx, y, z * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConyF.
- DCPx,y,z: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal (no uncertainty required). DCP does not depend on frequency nor media.
- Ax,y,z; Bx,y,z; Cx,y,z, VRx,y,z; A, B, C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f ≤ 800 MHz) and inside waveguide using analytical field distributions based on power measurements for f > 800 MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y.z. * CanvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.

Certificate No: E	X3-3592_Nov10	Page 2 of 11	

Testing Service	Appendix D for the BlackBerry Report	Page 16(53)		
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Probe EX3DV4

SN:3592

Manufactured: September 18, 2006
Last calibrated: November 17, 2009
Recalibrated: November 18, 2010

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No. EX3-3502_Nov10

Testin Service	Appendix D for the BlackBerr Report	Page 17(53)		
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

DASY/EASY - Parameters of Probe: EX3DV4 SN:3592

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm (µV/(V/m)²) ^A	0.49	0.47	0.41	± 10.1%
DCP (mV) ⁸	95.2	94.3	97.4	

Modulation Calibration Parameters

uib _	Communication System Name	PAR		A dB	B dBuV	С	VR mV	Une ² {k=2}
10000	cw	0.00	х	0.00	0.00	1 00	144.9	± 2.9 %
			Y	0.00	0.00	1.00	110.4	
			z	0.00	0.00	1.00	130.2	l

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: EX3-359Z_Nov10

 $^{^{\}prime}$ The uncertainties of NormX,Y,Z do not affect the E-field uncertainty inside TSL (see Fages 5 and 6).

^{*} Numerical linearization parameter uncertainty nat required

^{*} Uncertainty is determined using the maximum deviation from their response applying recatangular distribution and is expressed for the equate of the field value.

Testing Service	Appendix D for the BlackBerry Report	Page 18 (53)		
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

DASY/EASY - Parameters of Probe: EX3DV4 SN:3592

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz]	Validity [MHz] ^c	Parmittivity	Conductivity	CanvF X Co	nvFY Co	nv <u>F Z</u>	Alpha	Depth Unc (k=2)	
5200	± 50 / ± 100	$38.0\pm5\%$	4.66 ± 5%	4.50	4.50	4.50	0.45	1. 90 ± 13.1%	
5500	± 50 / ± 100	35.6 ± 5%	4 95 ± 5%	4.25	4.25	4.25	0.50	1.90 ± 13.1%	
5800	± 50 / ± 100	$35.3 \pm 5\%$	$5.27 \pm 5\%$	3.96	3.96	3.98	0.52	1.90 ± 13.1%	

[&]quot;The validity of ± 100 MHz only applies for CASY v4.4 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Testing Service	Appendix D for the BlackBerry Report	® Smartphone Model	REQ71UW SAR	Page 19(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

DASY/EASY - Parameters of Probe: EX3DV4 SN:3592

Calibration Parameter Determined in Body Tissue Simulating Media

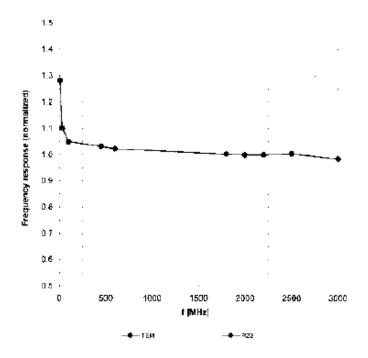
f [MHz]	Validity [MHz]°	Permittivity	Conductivity	ConvF X Co	nvFY Co	nvF Z	Alpha	Bepth Unc (k-2)	_
5200	$\pm 50 / \pm 100$	$49.0 \pm 5\%$	$5.30 \pm 5\%$	3.95	3.95	3.95	0.52	1 95 ± 13.1%	
\$500	± 50 / ± 100	48.6 ± 5%	5.65 ± 5%	3.73	3.73	3.73	0.65	1.95 ± 13.1%	
5800	±50/±100	48.2 ± 5%	$6.00 \pm 6\%$	3.40	3.40	3.40	0.63	1.95 ± 13.1%	

The validity of \$100 MHz only applies for DASY v4.4 and higher [see Page 2]. The uncerts highs the RSS of the Convit uncertainty at calibration frequency and the uncertainty for the vid called frequency band.

Tes Ser	ting vices	Appendix D for the BlackBerry Report	® Smartphone Model	REQ71UW SAR	Page 20 (53)
Author Data	D	ates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	S	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Frequency Response of E-Field

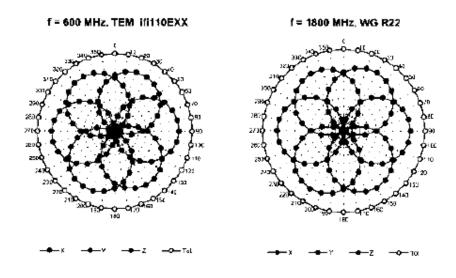
(TEM-Cell:ifi110 EXX, Waveguide: R22)

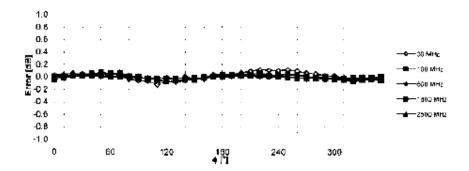


Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

Testing Service	Appendix D for the BlackBerry Report	y® Smartphone Model	REQ71UW SAR	Page 21 (53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

Receiving Pattern (ϕ), $\vartheta = 0^{\circ}$



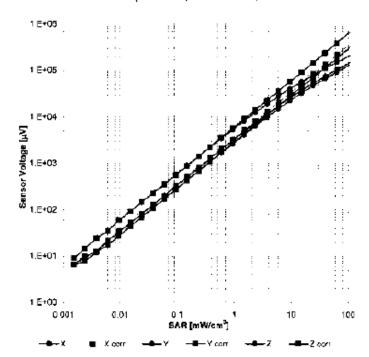


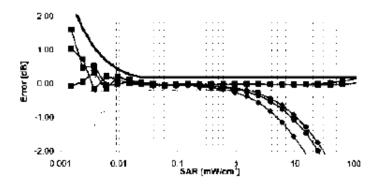
Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

Testing Service	Appendix D for the BlackBerry Report	y® Smartphone Model	REQ71UW SAR	Page 22(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

Dynamic Range f(SAR_{head})

(TEM cell, f = 900 MHz)

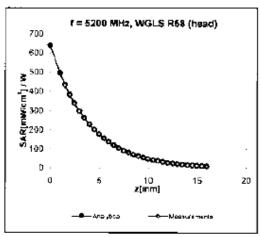


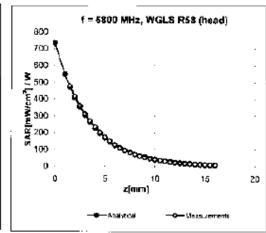


Uncertainty of Linearity Assessment: ± 0.6% (k=2)

Testing Service	Appendix D for the BlackBerry Report	® Smartphone Model	REQ71UW SAR	Page 23(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

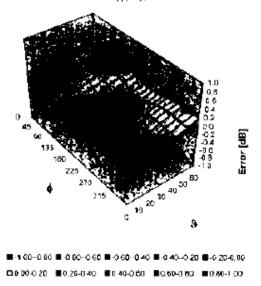
Conversion Factor Assessment





Deviation from Isotropy in HSL

Error (ϕ , 3), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: EX3-3592 Nov10

Peac 10 of 11

Testing Service	Appendix D for the BlackBerry Report	® Smartphone Model	REQ71UW SAR	Page 24(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (*)	Not applicable
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	9 mm
Tip Diameter	2.5 mm
Probe Tip to Sensor X Calibration Point	1 mm
Probe Tip to Sensor Y Calibration Point	1 mm
Probe Tip to Sensor Z Calibration Point	1 mm
Recommended Measurement Distance from Surface	2 mm



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

25(53)

Author Data Andrew Becker Dates of Test

September 27 - October 26, 2011

Test Report No

RTS-5955-1110-23

FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage

С Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA

Multilateral Agreement for the recognition of calibration certificates

RTS (RIM Testing Services)

Accreditation No.: SCS 108

Certificate No: D835V2-446_Jan11

CALIBRATION CERTIFICATE

D835V2 - SN: 446 Object

QA CAL-05.v8 Calibration procedure(s)

Calibration procedure for dipole validation kits

January 21, 2011 Calibration date:

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

GB37480704 US37292783 SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205 SN: 601	06-Oct-10 (No. 217-01266) 06-Oct-10 (No. 217-01266) 30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10)	Oct-11 Oct-11 Mar-11 Mar-11 Apr-11 Jun-11
SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10)	Mar-11 Mar-11 Apr-11
SN: 5047.2 / 06327 SN: 3205	30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10)	Mar-11 Apr-11
SN: 3205	30-Apr-10 (No. ES3-3205_Apr10)	Apr-11
		•
SN: 601	10-Jun-10 (No. DAE4-601_Jun10)	lun-11
	,	Juli-17
ID#	Check Date (in house)	Scheduled Check
MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
100005	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
US37390585 S4206	18-Oct-01 (in house check Oct-10)	In house check: Oct-11
Name	Function	Signature
	MY41092317 100005 US37390585 S4206 Name	MY41092317 18-Oct-02 (in house check Oct-09) 100005 4-Aug-99 (in house check Oct-09) US37390585 S4206 18-Oct-01 (in house check Oct-10)

Approved by:

Issued: January 21, 2011

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: D835V2-446_Jan11



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR

26(53)

Author Data Andrew Becker Dates of Test

September 27 – October 26, 2011

Test Report No RTS-5955-1110-23 FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst s Service suisse d'étalonnage С

Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossarv:

TSL

tissue simulating liquid

ConvF N/A

sensitivity in TSL / NORM x,y,z

not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)".
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

			_
Certificate No: D835V2-446_Jan11	Page 2 of 6		

Testing Service	Appendix D for the BlackBerry Report	® Smartphone Model	REQ71UW SAR	Page 27 (53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	15 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	835 MHz ± 1 MHz	

Head TSL parameters

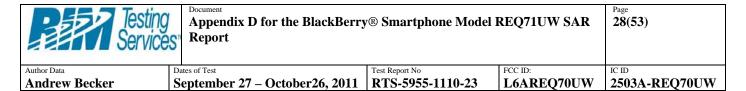
The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	41.5	0.90 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	41.3 ± 6 %	0.89 mho/m ± 6 %
Head TSL temperature during test	(21.8 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	2.39 mW / g
SAR normalized	normalized to 1W	9.56 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	9.63 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	1.56 mW / g
SAR normalized	normalized to 1W	6.24 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	6.27 mW /g ± 16.5 % (k=2)



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	49.6 Ω - 7.7 jΩ
Return Loss	- 22.2 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.386 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

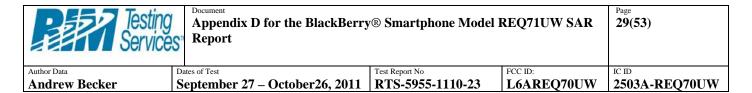
The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	October 24, 2001

Certificate No: D835V2-446_Jan11



DASY5 Validation Report for Head TSL

Date/Time: 21.01.2011 10:18:05

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 835 MHz; Type: D835V2; Serial: D835V2 - SN:446

Communication System: CW; Frequency: 835 MHz; Duty Cycle: 1:1

Medium: HSL900

Medium parameters used: f = 835 MHz; $\sigma = 0.89$ mho/m; $\varepsilon_r = 41.2$; $\rho = 1000$ kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(6.03, 6.03, 6.03); Calibrated: 30.04.2010

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 10.06.2010

Phantom: Flat Phantom 4.9L; Type: QD000P49AA; Serial: 1001

Measurement SW: DASY52, V52.6.1 Build (408)

Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

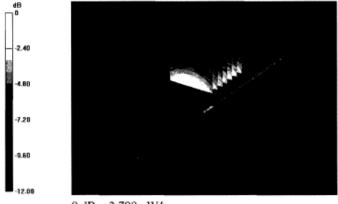
Pin=250 mW /d=15mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement

grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 57.426 V/m; Power Drift = 0.04 dB

Peak SAR (extrapolated) = 3.600 W/kg

SAR(1 g) = 2.39 mW/g; SAR(10 g) = 1.56 mW/gMaximum value of SAR (measured) = 2.790 mW/g



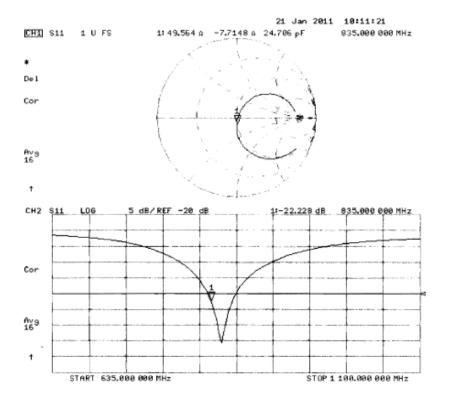
0 dB = 2.790 mW/g

Certificate No: D835V2-446_Jan11

Page 5 of 6

Author Data Document Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report Author Data Dates of Test Test Report No FCC ID:				Page 30(53)
Author Data	FCC ID:	IC ID		
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

Impedance Measurement Plot for Head TSL





Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

31(53)

Author Data **Andrew Becker** Dates of Test

September 27 – October 26, 2011

Test Report No

RTS-5955-1110-23

FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





s Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

na seria de la comunicación de la companya de la c

ALIBRATION	ERTIFICATE		
Object	D1900V2 - SN: 5	45	
Calibration procedure(s)	QA CAL-05.v8 Calibration proce	dure for dipole validation kits	
Calibration date:	January 13, 201	ke Roja sagan dan masah Abel da dasa Makaban dan Masah	
The measurements and the unce	ertainties with confidence p	ional standards, which realize the physical un robability are given on the following pages ar ry facility: environment temperature $(22 \pm 3)^{9}$	nd are part of the certificate.
Calibration Equipment used (M&	TE critical for calibration)		
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-10 (No. 217-01266)	Oct-11
ower sensor HP 8481A	US37292783	06-Oct-10 (No. 217-01266)	Oct-11
ower sensor HP 8481A leference 20 dB Attenuator	SN: 5086 (20g)	30-Mar-10 (No. 217-01158)	Oct-11 Mar-11
ower sensor HP 8481A leference 20 dB Attenuator lype-N mismatch combination	SN: 5086 (20g) SN: 5047.2 / 06327	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162)	Oct-11 Mar-11 Mar-11
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10)	Oct-11 Mar-11 Mar-11 Apr-11
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3	SN: 5086 (20g) SN: 5047.2 / 06327	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162)	Oct-11 Mar-11 Mar-11
tower sensor HP 8481A deference 20 dB Attenuator type-N mismatch combination deference Probe ES3DV3 DAE4	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10)	Oct-11 Mar-11 Mar-11 Apr-11 Jun-11
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3 DAE4	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205 SN: 601	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house)	Oct-11 Mar-11 Mar-11 Apr-11
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3 DAE4 Recondary Standards Power sensor HP 8481A	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205 SN: 601	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10)	Oct-11 Mar-11 Mar-11 Apr-11 Jun-11 Scheduled Check
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3 DAE4 Recondary Standards Power sensor HP 8481A RF generator R&S SMT-06	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205 SN: 601 ID # MY41092317	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house) 18-Oct-02 (in house check Oct-09)	Oct-11 Mar-11 Mar-11 Apr-11 Jun-11 Scheduled Check In house check: Oct-11
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3 DAE4 Recondary Standards Power sensor HP 8481A RF generator R&S SMT-06	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205 SN: 601 ID # MY41092317 100005	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr-10) 10-Jun-10 (No. DAE4-601_Jun10) Check Date (in house) 18-Oct-02 (in house check Oct-09) 4-Aug-99 (in house check Oct-09)	Oct-11 Mar-11 Mar-11 Apr-11 Jun-11 Scheduled Check In house check: Oct-11 In house check: Oct-11
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3 DAE4 Recondary Standards Power sensor HP 8481A RF generator R&S SMT-06 Network Analyzer HP 8753E	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205 SN: 601 ID # MY41092317 100005 US37390585 S4206	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr-10) 10-Jun-10 (No. DAE4-601_Jun-10) Check Date (in house) 18-Oct-02 (in house check Oct-09) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-10)	Oct-11 Mar-11 Mar-11 Apr-11 Jun-11 Scheduled Check In house check: Oct-11 In house check: Oct-11
Power sensor HP 8481A Reference 20 dB Attenuator Type-N mismatch combination Reference Probe ES3DV3 DAE4 Secondary Standards Power sensor HP 8481A RF generator R&S SMT-06 Network Analyzer HP 8753E Calibrated by: Approved by:	SN: 5086 (20g) SN: 5047.2 / 06327 SN: 3205 SN: 601 ID # MY41092317 100005 US37390585 S4206 Name	30-Mar-10 (No. 217-01158) 30-Mar-10 (No. 217-01162) 30-Apr-10 (No. ES3-3205_Apr-10) 10-Jun-10 (No. DAE4-601_Jun-10) Check Date (in house) 18-Oct-02 (in house check Oct-09) 4-Aug-99 (in house check Oct-09) 18-Oct-01 (in house check Oct-10) Function Laboratory Technician	Oct-11 Mar-11 Mar-11 Apr-11 Jun-11 Scheduled Check In house check: Oct-11 In house check: Oct-11

Certificate No: D1900V2-545_Jan11

Page 1 of 6



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR

Report

32(53)

Author Data Andrew Becker Dates of Test

September 27 – October 26, 2011

Test Report No

RTS-5955-1110-23

FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





С

Schweizerischer Kalibrierdienst s

Service suisse d'étalonnage Servizio svizzero di taratura

Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL

tissue simulating liquid

ConvF

sensitivity in TSL / NORM x,y,z not applicable or not measured

N/A

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- Federal Communications Commission Office of Engineering & Technology (FCC OET). "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Certificate	No: D	19000	2-545	Jan11	

Testing Services	Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report			Page 33(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V52.6
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	1900 MHz ± 1 MHz	

Head TSL parameters
The following parameters and calculations were applied.

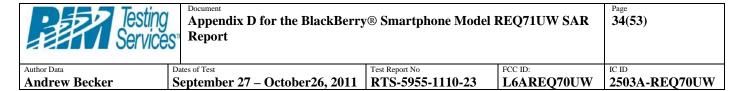
-	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	40.0	1.40 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	38.5 ± 6 %	1.43 mho/m ± 6 %
Head TSL temperature during test	(21.2 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	10.2 mW / g
SAR normalized	normalized to 1W	40.8 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	40.0 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	5.26 mW / g
SAR normalized	normalized to 1W	21.0 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	20.8 mW /g ± 16.5 % (k=2)

Certificate No: D1900V2-545_Jan11



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	50.8 Ω + 1.8 jΩ
Return Loss	- 34.4 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.199 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	November 15, 2001

Certificate No: D1900V2-545_Jan11

Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report			Page 35(53)	
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

DASY5 Validation Report for Head TSL

Date/Time: 13.01.2011 14:52:49

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 1900 MHz; Type: D1900V2; Serial: D1900V2 - SN:545

Communication System: CW; Frequency: 1900 MHz; Duty Cycle: 1:1

Medium: HSL U12 BB

Medium parameters used: f = 1900 MHz; $\sigma = 1.43 \text{ mho/m}$; $\varepsilon_r = 38.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(5.09, 5.09, 5.09); Calibrated: 30.04.2010

Sensor-Surface: 3mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 10.06.2010

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY52, V52.6.1 Build (408)

Postprocessing SW: SEMCAD X, V14.4.2 Build (2595)

Pin=250 mW /d=10mm, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) /Cube 0: Measurement

grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 98.053 V/m; Power Drift = 0.03 dB

Peak SAR (extrapolated) = 18.648 W/kg

SAR(1 g) = 10.2 mW/g; SAR(10 g) = 5.26 mW/gMaximum value of SAR (measured) = 12.743 mW/g

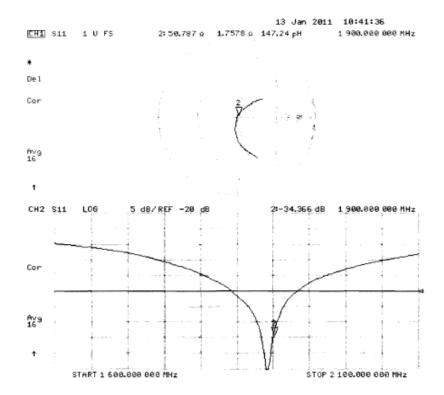


0 dB = 12.740 mW/g

Certificate No: D1900V2-545_Jan11

Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report				Page 36(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Impedance Measurement Plot for Head TSL



Page 6 of 6



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

37(53)

Author Data **Andrew Becker** Dates of Test

September 27 – October 26, 2011

Test Report No

RTS-5955-1110-23

FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst s Service suisse d'étalonnage С Servizio svizzero di taratura s Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates Accreditation No.: SCS 108

RTS (RIM Testing Services)

Certificate No: D2450V2-747_Nov09

Client nia (nim resu			
CALIBRATION C	ERTIFICATE		
Object	D2450V2 - SN: 7	47 ,	
Calibration procedure(s)	QA CAL-05,v7 Calibration proce	dure for dipole validation kits	
Calibration date:	November 11, 20	(09)	
The measurements and the unce	ertainties with confidence p	onal standards, which realize the physica robability are given on the following page by facility: environment temperature (22 ±	s and are part of the certificate.
		y launcy. Olivinosision temperature (22.2	o) o and normany 4 70%.
Calibration Equipment used (M&)	TE critical for calibration)		
Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-09 (No. 217-01086)	Oct-10
Power sensor HP 8481A	US37292783	06-Oct-09 (No. 217-01086)	Oct-10
Reference 20 dB Attenuator	SN: 5086 (20g)	31-Mar-09 (No. 217-01025)	Mar-10
Type-N mismatch combination	SN: 5047.2 / 06327	31-Mar-09 (No. 217-01029)	Mar-10
Reference Probe ES3DV3	SN: 3205	26-Jun-09 (No. ES3-3205_Jun09)	Jun-10
DAE4	SN: 601	07-Mar-09 (No. DAE4-601_Mar09)	Mar-10
Connedon Chandards	ID#	Charle Data for house?	Scheduled Check
Secondary Standards Power sensor HP 8481A	MY41092317	Check Date (in house)	
RF generator R&S SMT-06	100005	18-Oct-02 (in house check Oct-09) 4-Aug-99 (in house check Oct-09)	In house check: Oct-11 In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-09)	In house check: Oct-10
THE OF SOL	000103000000000000000000000000000000000	10-001-01 (all totals of the control	III III III III II II II II II II II II
Calibrated by:	Name Mike Medi	Function Laboratory Technician	Signature
Approved by:	Katja Pokovio	Technical Manager	A 19
This calibration cortificate shall n	of be reproduced except in	full without written approval of the labora	lasued: November 16, 2009

Certificate No: D2450V2-747_Nov09

Page 1 of 6



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR

Report

38(53)

Author Data Andrew Becker Dates of Test September 27 – October 26, 2011

Test Report No RTS-5955-1110-23 FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst

Service suisse d'étalonnage С

Accreditation No.: SCS 108

Servizio svizzero di taratura s Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL tissue simulating liquid

ConvF sensitivity in TSL / NORM x,y,z N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2003, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", December 2003
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)", February 2005
- c) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Certificate No: D2450V2-747_Nov09 Page 2 of 6

Testing Services	Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report			Page 39(53)
Author Data	tes of Test			IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V4.9	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy, dz = 5 mm	
Frequency	2450 MHz ± 1 MHz	

Head TSL parameters

The following parameters and calculations were applied.

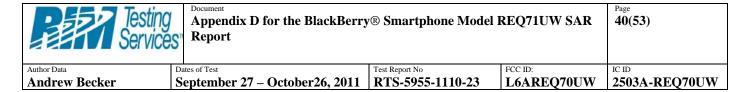
	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.1 ± 6 %	1.78 mho/m ± 6 %
Head TSL temperature during test	(21.3 ± 0.2) °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.3 mW / g
SAR normalized	normalized to 1W	53.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	53.4 mW /g ± 17.0 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	250 mW input power	6.23 mW / g
SAR normalized	normalized to 1W	24.9 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.9 mW /g ± 16.5 % (k=2)

Certificate No: D2450V2-747_Nov09



Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	51.9 Ω + 0.9 jΩ	
Return Loss	- 33.9 dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.161 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	December 01, 2003

Certificate No: D2450V2-747_Nov09 Page 4 of 6

Testing Service	n	Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR		
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW

DASY5 Validation Report for Head TSL

Date/Time: 11.11.2009 15:04:10

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:747

Communication System: CW; Frequency: 2450 MHz; Duty Cycle: 1:1

Medium: HSL U11 BB

Medium parameters used: f = 2450 MHz; $\sigma = 1.79 \text{ mho/m}$; $\varepsilon_r = 39.2$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: ES3DV3 - SN3205; ConvF(4.53, 4.53, 4.53); Calibrated: 26.06.2009

Sensor-Surface: 3mm (Mechanical Surface Detection)
 Electronics: DAE4 Sn601; Calibrated: 07.03.2009

Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001

Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Head/d=10mm, Pin=250 mW, dist=3.0mm (ES-Probe)/Zoom Scan (7x7x7) (7x7x7)/Cube 0:

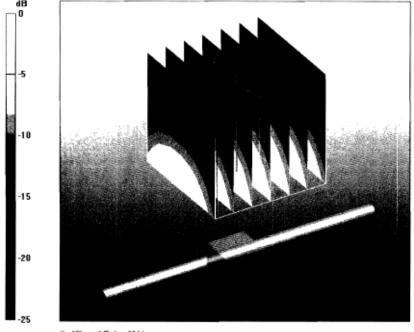
Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 101.3 V/m; Power Drift = 0.067 dB

Peak SAR (extrapolated) = 27 W/kg

SAR(1 g) = 13.3 mW/g; SAR(10 g) = 6.23 mW/g

Maximum value of SAR (measured) = 17.1 mW/g



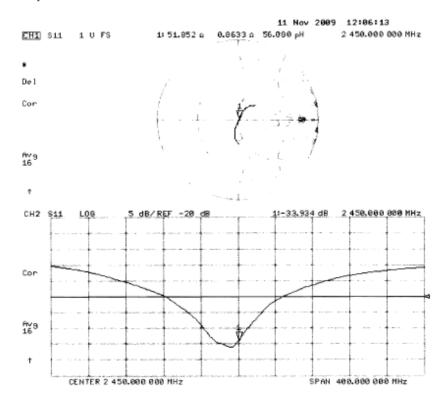
0 dB = 17.1 mW/g

Certificate No: D2450V2-747_Nov09

Page 5 of 6

Testing Service	Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR		Page 42(53)	
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Impedance Measurement Plot for Head TSL





Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report

43(53)

Author Data Andrew Becker Dates of Test

September 27 - October 26, 2011

Test Report No

RTS-5955-1110-23

FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst Service suisse d'étalonnage С Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

RTS (RIM Testing Services) Client

Accreditation No.: SCS 108

Certificate No: D5GHzV2-1033 Nov09

CALIBRATION CERTIFICATE

Object D5GHzV2 - SN: 1033

QA CAL-22.v1 Calibration procedure(s)

Calibration procedure for dipole validation kits between 3-6 GHz

November 13, 2009 Calibration date:

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (Si). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID#	Cal Date (Certificate No.)	Scheduled Calibration
Power meter EPM-442A	GB37480704	06-Oct-09 (No. 217-01086)	Oct-10
Power sensor HP 8481A	U\$37292783	06-Oct-09 (No. 217-01086)	Oct-10
Reference 20 dB Attenuator	SN: 5086 (20g)	31-Mar-09 (No. 217-01025)	Mar-10
Type-N mismatch combination	SN: 5047.2 / 06327	31-Mar-09 (No. 217-01029)	Mar-10
Reference Probe EX3DV4	SN: 3503	11-Mar-09 (No. EX3-3503_Mar09)	Mar-10
DAE4	SN: 601	07-Mar-09 (No. DAE4-601_Mar09)	Mar-10
Secondary Streeterds	ID#	Charle Data (in house)	Sahadulad Charle
Secondary Standards	10#	Check Date (in house)	Scheduled Check
Power sensor HP 8481A	MY41092317	18-Oct-02 (in house check Oct-09)	In house check: Oct-11
RF generator R&S SMT-06	100005	4-Aug-99 (in house check Oct-09)	In house check: Oct-11
Network Analyzer HP 8753E	US37390585 S4206	18-Oct-01 (in house check Oct-09)	In house check: Oct-10

Name Function Calibrated by: Jeton Kastrati Laboratory Technician

Approved by: Katja Pokovic Technical Manager

Issued: November 16, 2009

This calibration certificate shall not be reproduced except in full without written approval of the laboratory

Certificate No: D5GHzV2-1033_Nov09

Page 1 of 11



Author Data

Andrew Becker

Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR

44(53)

Report

Dates of Test

September 27 - October 26, 2011

Test Report No RTS-5955-1110-23 FCC ID: L6AREQ70UW IC ID 2503A-REQ70UW

Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland





Schweizerischer Kalibrierdienst S

Service suisse d'étalonnage С Servizio svizzero di taratura

S Swiss Calibration Service

Accreditation No.: SCS 108

Accredited by the Swiss Accreditation Service (SAS)

The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL

tissue simulating liquid

ConvF

sensitivity in TSL / NORM x,v,z

N/A not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEC Std 62209 Part 2, "Evaluation of Human Exposure to Radio Frequency Fields from Handheld and Body-Mounted Wireless Communication Devices in the Frequency Range of 30 MHz to 6 GHz; Human models, Instrumentation, and Procedures"; Part 2: "Procedure to determine the Specific Absorption Rate (SAR) for including accessories and multiple transmitters", Draft Version 0.9, December 2004
- b) Federal Communications Commission Office of Engineering & Technology (FCC OET), "Evaluating Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields; Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits for Human Exposure to Radiofrequency Emissions", Supplement C (Edition 01-01) to Bulletin 65

Additional Documentation:

c) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

Certificate No: D5GHzV2-1033_Nov09

Page 2 of 11

Testing Services	Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report			Page 45(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY5	V5.2
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Area Scan resolution	dx, dy = 10 mm	
Zoom Scan Resolution	dx, dy = 4.0 mm, dz = 2.5 mm	
Frequency	5200 MHz ± 1 MHz 5500 MHz ± 1 MHz 5800 MHz ± 1 MHz	

Head TSL parameters at 5200 MHz

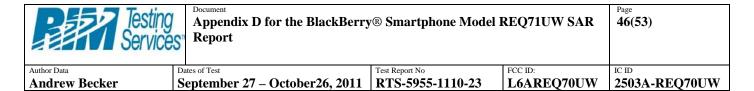
The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	36.0	4.66 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	35.4 ± 6 %	4.54 mho/m ± 6 %
Head TSL temperature during test	(22.5 ± 0.2) °C		

SAR result with Head TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	condition	
SAR measured	100 mW input power	7.75 mW / g
SAR normalized	normalized to 1W	77.5 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	77.2 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.19 mW / g
SAR normalized	normalized to 1W	21.9 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	21.8 mW / g ± 19.5 % (k=2)



Head TSL parameters at 5500 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.6	4.96 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	35.6 ± 6 %	4.93 mho/m ± 6 %
Head TSL temperature during test	(22.5 ± 0.2) °C		

SAR result with Head TSL at 5500 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	condition	
SAR measured	100 mW input power	8.29 mW / g
SAR normalized	normalized to 1W	82.9 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	82.9 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.32 mW / g
SAR normalized	normalized to 1W	23.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	23.2 mW / g ± 19.5 % (k=2)

Head TSL parameters at 5800 MHz

The following parameters and calculations were applied.

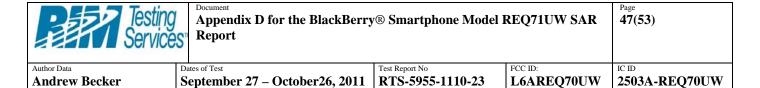
	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	34.2 ± 6 %	5.10 mho/m ± 6 %
Head TSL temperature during test	(22.5 ± 0.2) °C		

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	condition	
SAR measured	100 mW input power	7.62 mW / g
SAR normalized	normalized to 1W	76.2 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	75.6 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.15 mW / g
SAR normalized	normalized to 1W	21.5 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	21.3 mW / g ± 19.5 % (k=2)

Certificate No: D5GHzV2-1033_Nov09 Page 4 of 11



Body TSL parameters at 5500 MHz

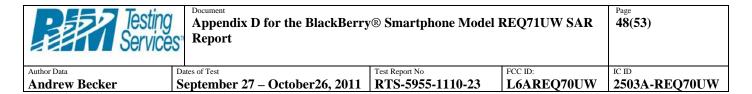
The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.6	5.65 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	47.5 ± 6 %	5.86 mho/m ± 6 %
Body TSL temperature during test	(22.5 ± 0.2) °C		

SAR result with Body TSL at 5500 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	condition	
SAR measured	100 mW input power	8.22 mW / g
SAR normalized	normalized to 1W	82.2 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	81.9 mW / g ± 19.9 % (k=2)

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.28 mW / g
SAR normalized	normalized to 1W	22.8 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	22.7 mW / g ± 19.5 % (k=2)



Appendix

Antenna Parameters with Head TSL at 5200 MHz

Impedance, transformed to feed point	50.1 Ω - 9.2 JΩ
Return Loss	-20.7 dB

Antenna Parameters with Head TSL at 5500 MHz

Impedance, transformed to feed point	51.2 Ω - 4.2 jΩ
Return Loss	-27.3 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance, transformed to feed point	56.0 Ω - 2.6 jΩ	
Return Loss	-24.2 dB	

Antenna Parameters with Body TSL at 5500 MHz

Impedance, transformed to feed point	51.1 Ω - 3.0 jΩ
Return Loss	-29.9 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.202 ns

After long term use with 40 W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	July 09, 2004

Certificate No: D5GHzV2-1033_Nov09

Testing Service	Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report			Page 49 (53)	
Author Data	Dates of Test	s of Test Test Report No FCC ID:			
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REO70UW	

DASY5 Validation Report for Head TSL

Date/Time: 12.11.2009 13:12:49

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN:1033

Communication System: CW; Frequency: 5200 MHz, Frequency: 5500 MHz, Frequency: 5800 MHz; Duty

Cycle: 1:1

Medium: HSL 3-6 GHz

Medium parameters used: f = 5200 MHz; $\sigma = 4.53$ mho/m; $\varepsilon_r = 35.4$; $\rho = 1000$ kg/m³, Medium parameters used: f = 5500 MHz; $\sigma = 4.81$ mho/m; $\varepsilon_r = 34.8$; $\rho = 1000$ kg/m³, Medium parameters used: f = 5800

MHz; $\sigma = 5.08 \text{ mho/m}$; $\varepsilon_r = 34.3$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

- Probe: EX3DV4 SN3503; ConvF(5.36, 5.36, 5.36), ConvF(4.85, 4.85, 4.85), ConvF(4.74, 4.74, 4.74); Calibrated: 11.03.2009
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn601; Calibrated: 07.03.2009
- Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Configuration D5GHzV2 Dipole (Head)/d=10mm, Pin=250mW, f=5200 MHz/Area Scan

(91x91x1): Measurement grid: dx=10mm, dy=10mm Maximum value of SAR (interpolated) = 15.4 mW/g

Configuration D5GHzV2 Dipole/d=10mm, Pin=250mW, f=5200 MHz/Zoom Scan (4x4x2.5mm), dist=2mm (8x8x10)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=2.5mm

Reference Value = 64.7 V/m; Power Drift = 0.035 dB

Peak SAR (extrapolated) = 30 W/kg

SAR(1 g) = 7.75 mW/g; SAR(10 g) = 2.19 mW/gMaximum value of SAR (measured) = 15.3 mW/g

Configuration D5GHzV2 Dipole/d=10mm, Pin=250mW, f=5500 MHz/Zoom Scan

(4x4x2.5mm), dist=2mm (8x8x10)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=2.5mm

Reference Value = 65.4 V/m; Power Drift = 0.057 dB

Peak SAR (extrapolated) = 33.8 W/kg

SAR(1 g) = 8.29 mW/g; SAR(10 g) = 2.32 mW/gMaximum value of SAR (measured) = 16.5 mW/g

Configuration D5GHzV2 Dipole/d=10mm, Pin=250mW, f=5800 MHz/Zoom Scan

(4x4x2.5mm), dist=2mm (8x8x10)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=2.5mm

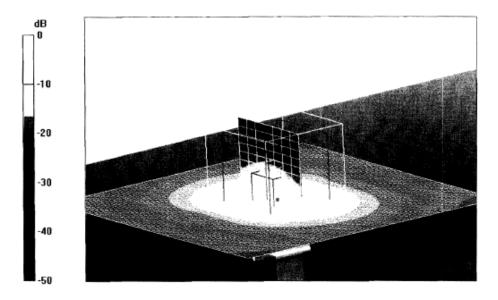
Reference Value = 61.7 V/m; Power Drift = 0.067 dB

Peak SAR (extrapolated) = 32.4 W/kg

SAR(1 g) = 7.62 mW/g; SAR(10 g) = 2.15 mW/g

Certificate No: D5GHzV2-1033_Nov09 Page 7 of 11

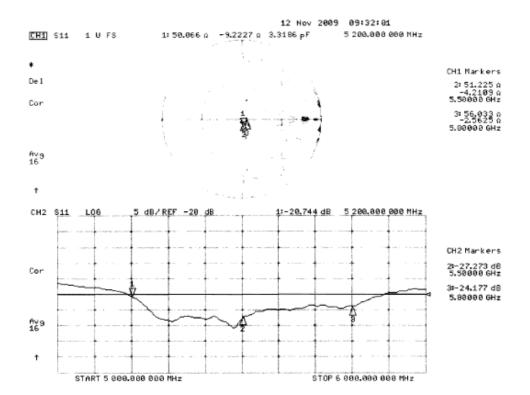
Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report				Page 50(53)
Author Data	IC ID			
Andrew Becker September 27 - October 26 2011 RTS-5955-1110-23 L6ARFO70UW				2503A-REO70HW



0~dB=15.3mW/g

Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report				Page 51(53)
Author Data	Dates of Test	IC ID		
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Impedance Measurement Plot for Head TSL



Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report				Page 52(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREO70UW	2503A-REQ70UW

DASY5 Validation Report for Body TSL

Date/Time: 13.11.2009 12:28:18

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN:1033

Communication System: CW; Frequency: 5500 MHz; Duty Cycle: 1:1

Medium: MSL 3-6 GHz

Medium parameters used: f = 5500 MHz; $\sigma = 5.83 \text{ mho/m}$; $\varepsilon_r = 47.6$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

DASY5 Configuration:

Probe: EX3DV4 - SN3503; ConvF(4.37, 4.37, 4.37); Calibrated: 11.03.2009

Sensor-Surface: 2mm (Mechanical Surface Detection)

Electronics: DAE4 Sn601; Calibrated: 07.03.2009

Phantom: Flat Phantom 5.0 (back); Type: QD000P50AA; Serial: 1002

Measurement SW: DASY5, V5.2 Build 157; SEMCAD X Version 14.0 Build 57

Configuration D5GHzV2 Dipole/d=10mm, Pin=250mW, f=5500 MHz/Area Scan

(91x91x1): Measurement grid: dx=10mm, dy=10mm Maximum value of SAR (interpolated) = 16.2 mW/g

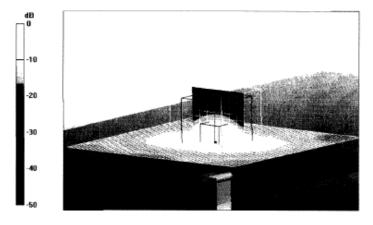
Configuration D5GHzV2 Dipole/d=10mm, Pin=250mW, f=5500 MHz/Zoom Scan

(4x4x2.5mm), dist=2mm (8x8x10)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=2.5mm

Reference Value = 59.5 V/m; Power Drift = -0.044 dB

Peak SAR (extrapolated) = 33.3 W/kg

SAR(1 g) = 8.22 mW/g; SAR(10 g) = 2.28 mW/gMaximum value of SAR (measured) = 16.4 mW/g



0 dB = 16.4 mW/g

Appendix D for the BlackBerry® Smartphone Model REQ71UW SAR Report				Page 53(53)
Author Data	Dates of Test	Test Report No	FCC ID:	IC ID
Andrew Becker	September 27 – October 26, 2011	RTS-5955-1110-23	L6AREQ70UW	2503A-REQ70UW

Impedance Measurement Plot for Body TSL

